



US00D410080S

United States Patent [19]

Heidsiek et al.

[11] Patent Number: **Des. 410,080**

[45] Date of Patent: **** May 18, 1999**

[54] **DIAGNOSTIC TESTING INSTRUMENT**

D. 326,908	6/1992	Gilbert et al.	D24/107
D. 369,564	5/1996	Whitby et al.	D24/234
5,147,610	9/1992	Watanabe et al.	422/64
5,270,210	12/1993	Weyrauch et al.	422/64 X

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Attorney, Agent, or Firm—Charles B. Cappellari

[73] Assignee: **Gen-Probe Incorporated**, San Diego, Calif.

[57] CLAIM

[**] Term: **14 Years**

The design for a diagnostic testing instrument, as shown and described.

[21] Appl. No.: **29/078,352**

DESCRIPTION

[22] Filed: **Oct. 13, 1997**

[51] **LOC (6) Cl.** **29-02**

[52] **U.S. Cl.** **D24/107**

[58] **Field of Search** D24/107, 185, D24/186, 234; 128/630, 906; 422/50, 62, 64; 436/43-45, 55; 364/140.09, 497, 480, 180

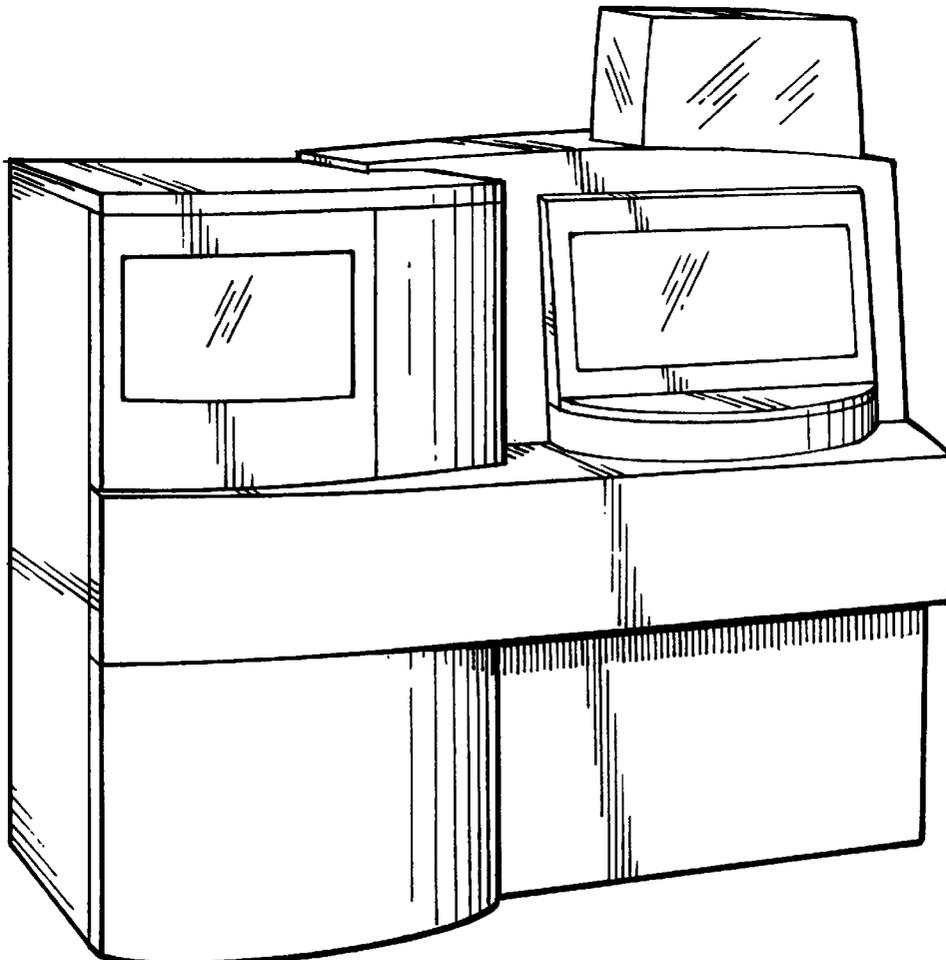
FIG. 1 is a top, front and left side perspective view of our new design for a diagnostic testing instrument;
FIG. 2 is a top, front and right side perspective view thereof;
FIG. 3 is a front elevation view thereof;
FIG. 4 is a plan view thereof;
FIG. 5 is a rear elevation view thereof;
FIG. 6 is a left side elevation view thereof; and,
FIG. 7 is right side elevation view thereof.

[56] References Cited

U.S. PATENT DOCUMENTS

D. 282,203 1/1986 Leonard et al. D24/107

1 Claim, 5 Drawing Sheets



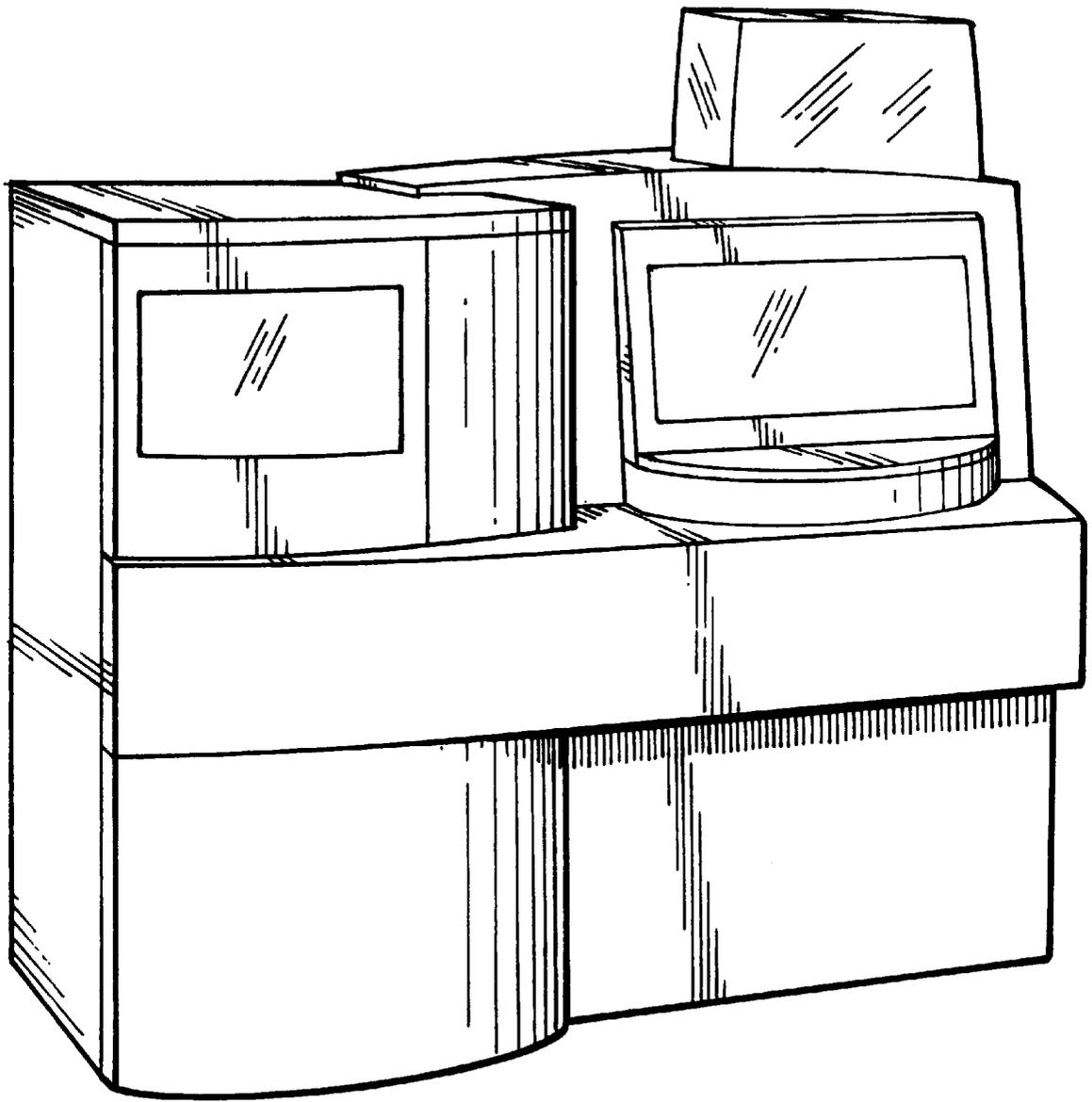


Fig. 1

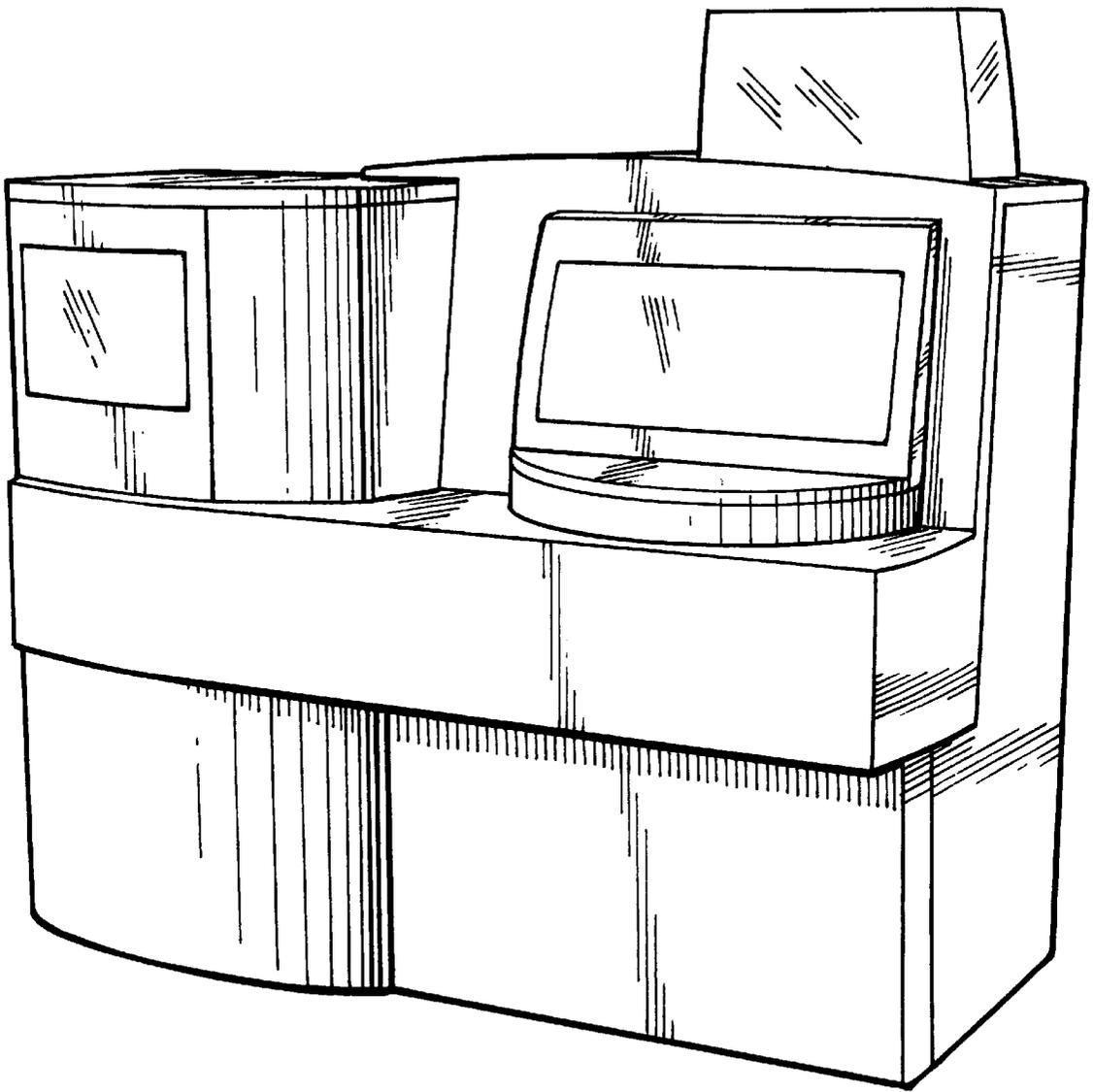


Fig. 2

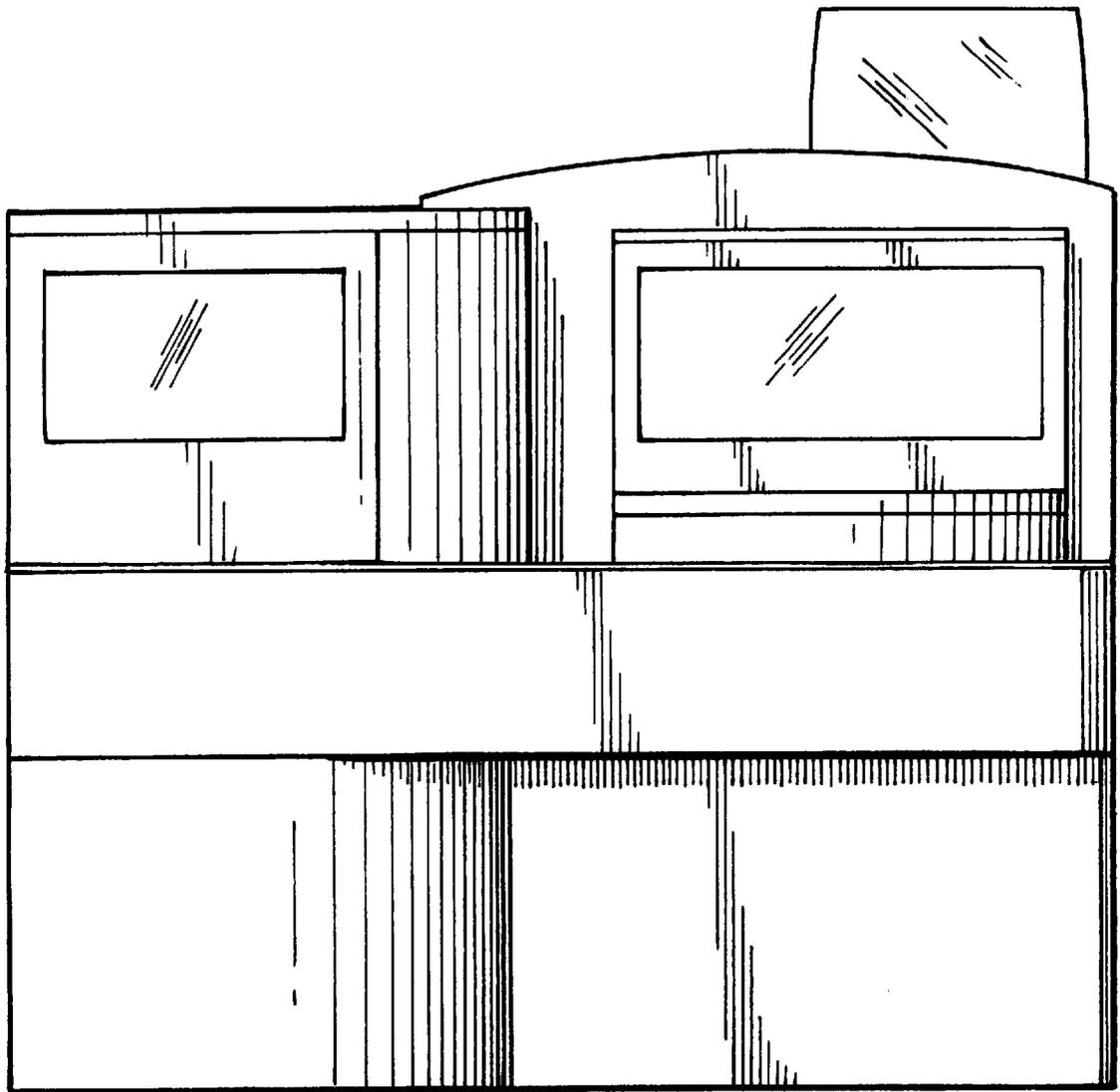


Fig. 3

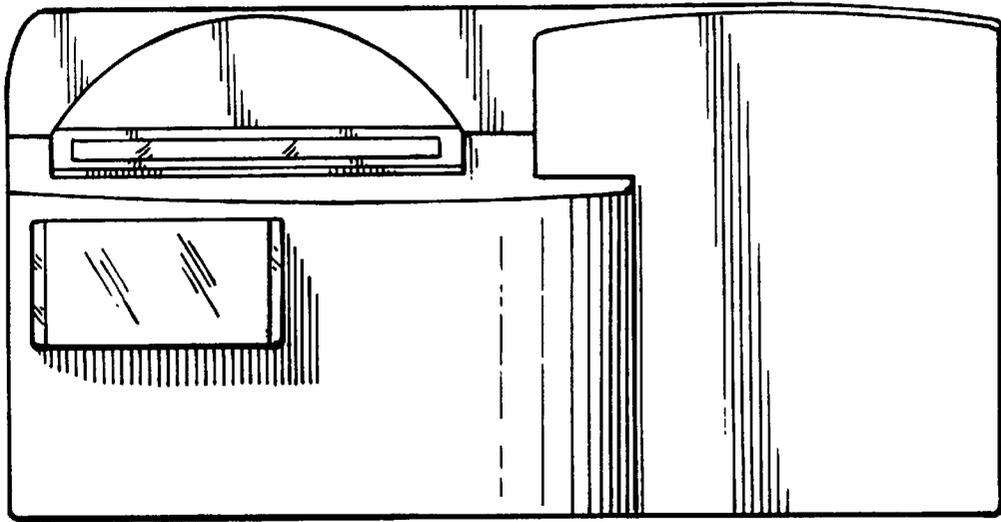


Fig. 4

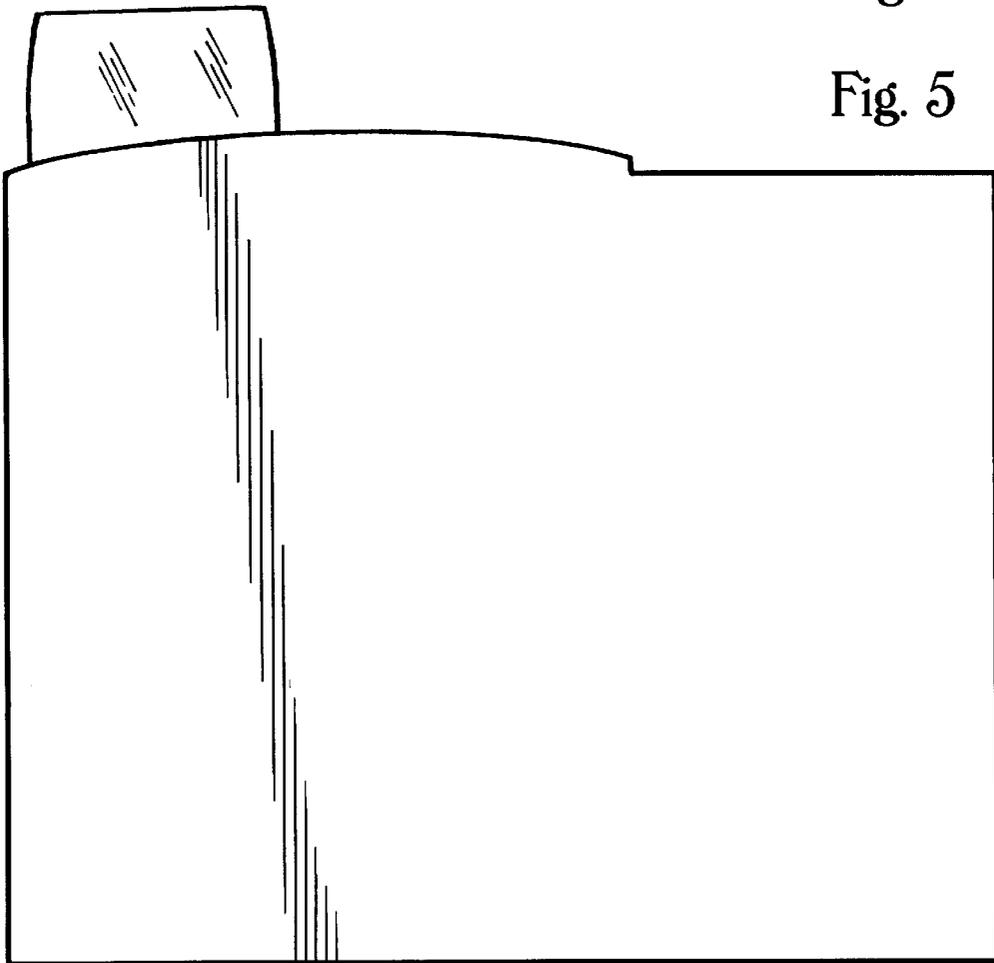


Fig. 5

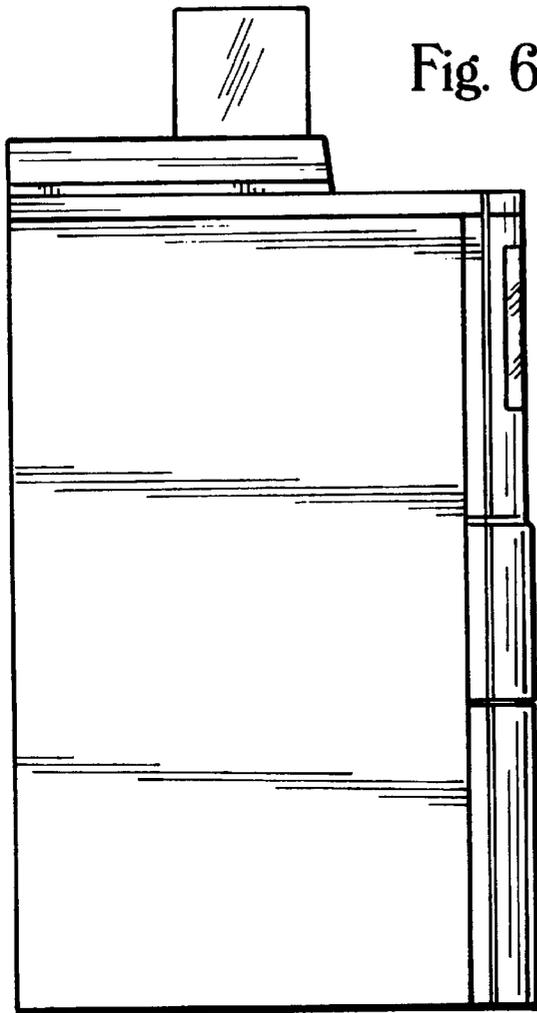


Fig. 6

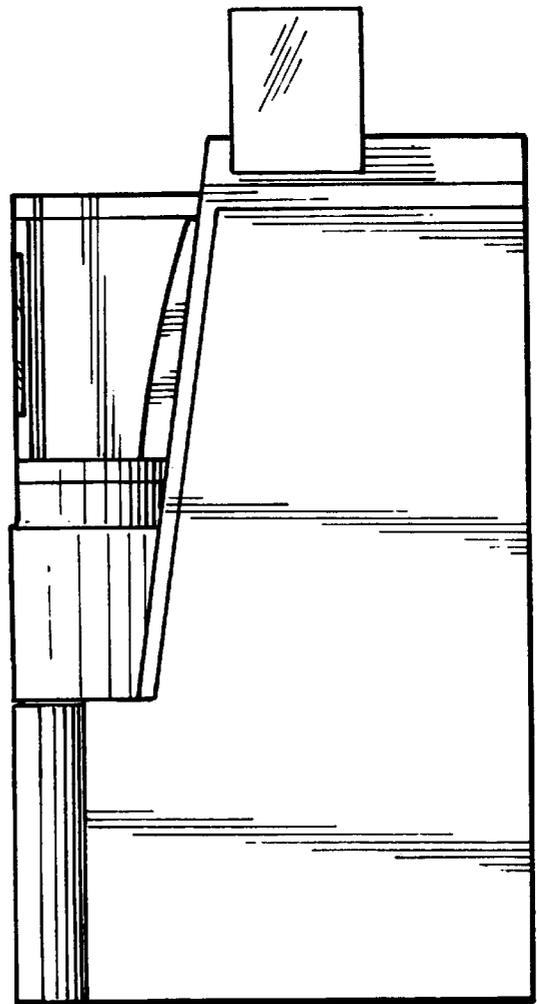


Fig. 7